


<b>Search Notes</b>  	<b>Application/Control No.</b>  10629033	<b>Applicant(s)/Patent Under Reexamination</b>  MAYO ET AL.
	<b>Examiner</b>  Wai, Eric C	<b>Art Unit</b>  2195

SEARCHED			
Class	Subclass	Date	Examiner
709	229, 219,226,201	03/07/07	ECW
713	324,330	3/24/2009	ECW
600	407	03/07/07	ECW
718	102-105	4/17/2008	ECW

SEARCH NOTES		
Search Notes	Date	Examiner
Inventor's Name Search	03/07/07	ECW
East Search	03/07/07	ECW
Updated Search	10/10/2007	ECW
Google Scholar Search	10/10/2007	ECW
Updated East Search	4/17/2008	ECW
Updated East Search	10/24/2008	ECW
Updated East Search	3/24/2009	ECW
Updated East Search	11/02/2009	ECW

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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